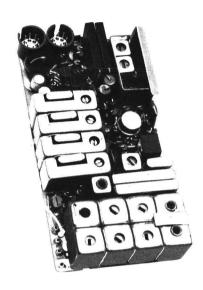
# MASTR<sup>®</sup> Personal

450-470 MHz, RECEIVER TYPE ER-72-A



# **SPECIFICATIONS** \*

Audio Output (EIA)

Channel Spacing

Sensitivity

12 dB SINAD (EIA Method)

20 dB Quieting Method

Selectivity

EIA Two-Signal

20 dB Quieting Method

Spurious Response

Intermodulation (EIA)

Audio Response

Modulation Acceptance

Squelch Sensitivity

Critical Squelch

Maximum Squelch

Maximum Frequency Spacing

500 milliwatts at less than 5% distortion

25 kHz

0.35 μV

 $0.50 \mu V$ 

-70 dB at  $\pm$  25 kHz

-110 dB at ±25 kHz

-60 dB

-60 dB

Within +2 and -10 dB of a standard 6 dB per octave de-emphasis curve from 300 to 3000 Hz (1000 Hz reference)

±7.5 kHz

0.25 kHz

Greater than 20 dB Quieting

Full Performance

1dB Degradation

0.60 MHz

1.20 MHz

hese specifications are intended primarily for the use of the serviceman. Refer to the appropriate Specification Sheet for the complete specifications.

# TABLE OF CONTENTS

SPECIFICATIONS	Cover
DESCRIPTION	1
CIRCUIT ANALYSIS	1
Oscillator Module Compensator Buffer/Tripler Front End Crystal Filter Second Mixer and Oscillator IF Amplifier Driver/Limiter and Ratio Detector Audio Amplifier Audio PA Squelch	1 1 1 3 3 3 4 4 5 5
MAINTENANCE	
Alignment Procedure Test Procedure	7 8
OUTLINE DIAGRAM	10
SCHEMATIC DIAGRAMS	
Front End Receiver Board	11 11
PARTS LIST AND PRODUCTION CHANGES	12
TROUBLESHOOTING PROCEDURES	13
ILLUSTRATIONS	
Figure 1 - Receiver Block Diagram  Figure 2 - Typical Oscillator Circuit  Figure 3 - Typical Compensator Circuit  Figure 4 - Typical 2nd Mixer and Oscillator Circuit  Figure 5 - Typical IF Amplifier Circuit  Figure 6 - Typical Driver/Limiter and Ratio Detector Circuit  Figure 7 - Typical Audio Amplifier Circuit  Figure 8 - Typical Squelch Circuit  Figure 9 - Test Setup for 20-Hz Double Trace Sweep Alignment  Figure 10 - Detector Probe for Sweep Alignment	2 3 3 4 4 5 7 7

# --- WARNING ----

No one should be permitted to handle any portion of the equipment that is supplied with high voltage; or to connect any external apparatus to the units while the units are supplied with power. KEEP AWAY FROM LIVE CIRCUITS.

### DESCRIPTION

General Electric MVP Personal Receiver Type ER-72-A, is a one through six-frequency, dual conversion FM receiver for operation in the 450 MHz to 470 MHz range. The receiver is constructed on a single printed wire board and utilizes both discrete components and Integrated Circuit Modules.

References to symbol numbers mentioned in the following text are found on the Schematic Diagram, Outline Diagram and Parts List (see Table of Contents). The typical circuit diagrams used in the text are representative of the circuits used in the Integrated Circuit Modules. A block diagram of the receiver is shown in Figure 1.

Supply voltage for the receiver includes a continuous 7.5 Volts for the squelch module, and a switched 7.5 Volts for the remaining receiver stages.

### CIRCUIT ANALYSIS

# OSCILLATOR MODULE

Oscillator Model 4EG28A28 (450-470 MHz) is a crystal-controlled Colpitts oscillator (see Figure 2). The entire oscillator is contained in a metal can with the receiver operating frequency printed on the top. The crystal frequency ranges from 20.48 to 22.38 MHz, and the crystal frequency is multiplied 21 times.

The oscillator frequency is temperature compensated to provide instant frequency compensation, with a frequency stability of  $\pm .0002\%$  from 0°C to +55°C and  $\pm .0005\%$  from -30°C to +60°C. The temperature compensation network is contained in Compensator Module A3 on the System Board.

In multi-frequency receivers, additional oscillator modules are mounted on the receiver board. The single-frequency supply jumper is removed, and the proper frequency is selected by connecting the 5.4 Volts to the selected oscillator module through frequency selector switch S1 on the control unit.

Complete instructions for multi-freqquency modifications are contained in the Multi-Frequency Modification Diagram (Refer to LBI-4900).

---- NOTE ----

All oscillator modules are individually compensated at the factory and cannot be repaired in the field. Any attempt to remove the oscillator cover will void the warranty.

### COMPENSATOR

Compensator module A3 contains the temperature compensation network for the oscillator (see Figure 3).

The regulated 5.4 Volts at Pin 2 is applied to a thermistor-compensated voltage divider. The output at Pin 3 (2.35 Volts measured with a VTVM) is applied to Pin 3 and to the varactor in the Oscillator module. At temperatures below -10°C, the compensated voltages increases to maintain the proper voltage on the oscillator voltage-variable capacitor.

### - SERVICE NOTE -

An abnormally low VTVM reading (or no reading) at Pin 3 may indicate a short or leakage path in the oscillator. This can be checked by unsoldering Pin 3, raising it off of the printed board, and taking another reading. If this reading is normal, the problem is in the Oscillator module. If the reading remains low (or zero), the problem is in the Compensator.

### BUFFER/TRIPLER

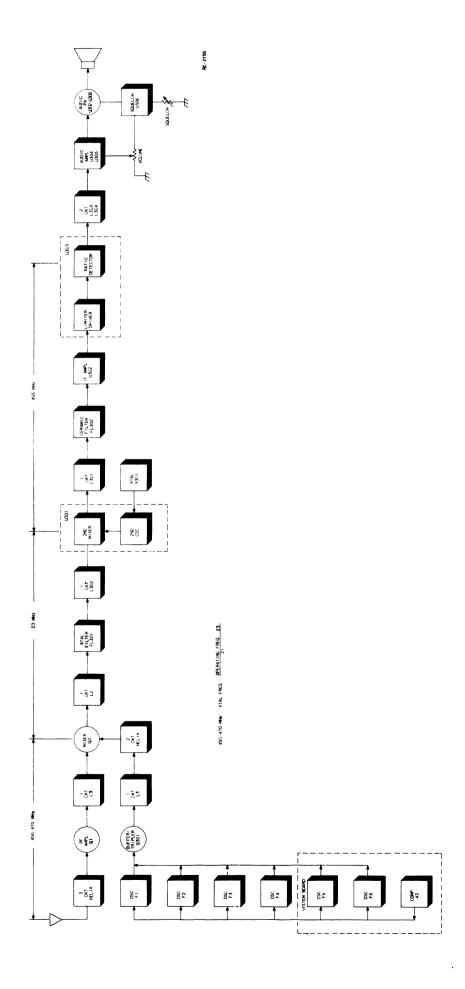
RF from the oscillator module is coupled to the base of Buffer/Tripler transsistor Q301. Q301 prevents loading of the oscillator modules by the receiver Front End. L3, in the multiplier circuit of the receiver Front End, is part of the collector circuit of Q301 and is tuned to three times the oscillator frequency. Three times the oscillator frequency is metered at Multi-Test Point (TP5) on the receiver board.

# RECEIVER FRONT END

The receiver Front End consists of three tuned helical resonators, an RF amplifier stage, a mixer stage and a multiplier circuit. RF from the antenna is coupled to a tap on Lll/Ll6. The tap is positioned to provide the proper impedance match to the antenna. RF energy is coupled to the third coil (Ll3/Ll8) through openings in the sides of the cans. RF is then coupled from a tap on Ll3/Ll8 through C8 to the base of RF amplifier transistor Ql. The output of Ql is developed across tuned circuit Cl0 and L3, and is applied to the base of the mixer transistor Q2 to be beat against the low-side injection frequency from the Multiplier Circuit.

The output of L3 in the multiplier circuit is applied to the anode of multiplier diode CR1. The two helical resonators following CR1 are tuned to seven times the first multiplier frequency for a total multiplication of 21 times. The output of





the helical resonators is direct-coupled to the emitter of the mixer transistor Q2. With the RF signal from the RF amplifier applied to the base of mixer Q2 and the low side injection frequency from the multiplier circuit applied to the emitter, the resultant 23 MHz IF frequency is coupled through the mixer collector tuned circuit (L2 & C6) to Crystal Filter FL301.

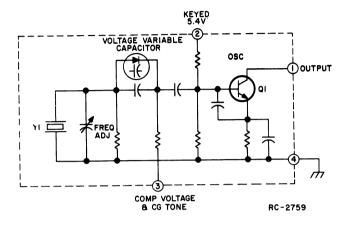


Figure 2 - Typical Oscillator Circuit

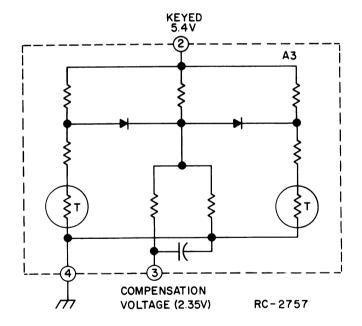


Figure 3 - Typical Compensator Circuit

# CRYSTAL FILTER

Crystal Filter FL301 follows the receiver Front End mixer stage and provides a minimum of 40 dB stop-band attenuation at

23 MHz. The output of FL301 is coupled through L302 to 2nd Mixer and Oscillator Module U301-1.

### 2ND MIXER AND OSCILLATOR

The 23 megahertz signal coupled to the 2nd Mixer and Oscillator Module U301-1 is coupled to the base of 2nd Mixer transistor Q2. Also coupled to the base of Q2 is a 22.545 megahertz low side injection frequency from Colpitts oscillator Q1. The 23 megahertz High-IF signal and the 22.545 megahertz low side injection frequency, produce a 455 kilohertz Low-IF output at U301-4. A typical 2nd mixer and oscillator circuit is shown in Figure 4.

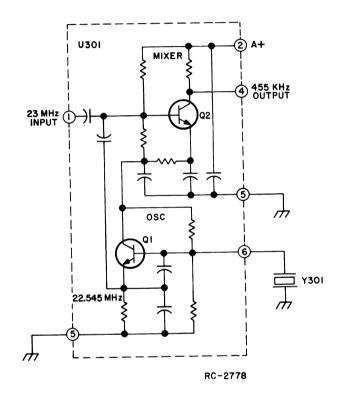


Figure 4 - Typical 2nd Mixer and Oscillator Circuit

The 455 Kilohertz Low-IF from 2nd Mixer and Oscillator Module U301-4 is coupled through Low-IF Filter L301 and Low-IF Ceramic Filter FL302. L301 and FL302 provide additional selectivity for the receiver. The output from L301 and FL302 is metered at TP4 and coupled to Low-IF Amplifier U302-6.

### IF AMPLIFIER

The 455 kilohertz Low-IF coupled to IF Amplifier U302-6 is applied to the base of amplifier Q1. A typical IF-amplifier circuit is shown in Figure 5.

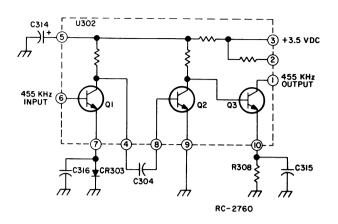


Figure 5 - Typical IF Amplifier Circuit

Further amplification is obtained through Q2 and Q3. The output of Q3 is applied to U302-1.

### DRIVER/LIMITER AND RATIO DETECTOR

The 455 kilohertz Low-IF from IF Amplifier U302-1 is connected to Driver/Limiter and Ratio Detector Module U303-1. A Typical Driver/Limiter and Ratio Detector Circuit is shown in Figure 6.

The Low-IF is applied to the base of Driver/Limiter transistor Q1. The output of Q1 is connected to U303-6 and applied directly to the Ratio Detector Circuit through L303 and L304. Diodes CR1 and CR2 rectify the Low-If. Voltages, the sum of which always remain constant, develop across resistors R1 and R2. Audio is developed as a result of the varying ratio of the voltages across R1 and R2. C1 stabilizes the circuit and keeps the sum of the voltages across R1 and R2 constant. The recovered audio is coupled from U303-9 through low pass filter R326 and C308. to Audio Amplifier Module U304/U305-1.

### AUDIO AMPLIFIER

Audio and noise from Ratio Detector U303 is applied to Audio Amplifier module U304/U305-1. (U305 in Channel Guard applications). A typical audio amplifier circuit is shown in Figure 7.

Audio and noise is applied to the base of Q1. This stage operates as an emitter-follower for matching the impedance of the ratio detector to amplifier transistor Q2 and VOLUME control R701. The output of Q1 connects from Pin 2 to the base of amplifier Q2 (Pin 4) through the VOLUME control. The output of Q1 is also applied to the input of Squelch module U306.

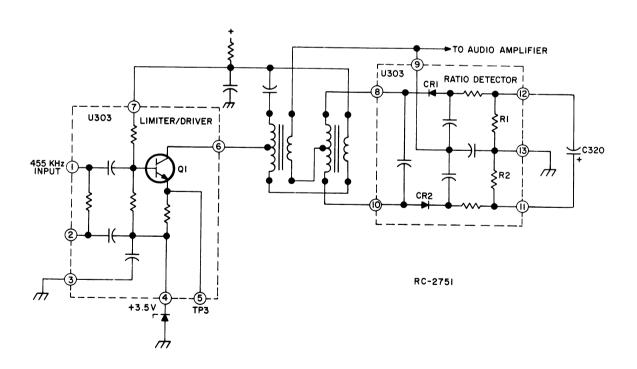


Figure 6 - Typical Driver/Limiter and Ratio Detector Circuit

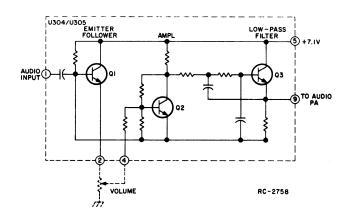


Figure 7 - Typical Audio Amplifier Circuit

Following amplifier Q2 is active low-pass filter Q3. Audio from the filter is connected from Pin 9 to Audio PA transistor Q302. In Audio Amplifier module U310, an active high-pass filter to provide the required tone frequency roll-off.

### AUDIO PA

When the receiver is quieted by a signal, audio from the active filter, in Audio Amplifier Module U304/U305, is coupled to the base of amplifier transistor Q302. The output of Q302 is direct coupled to the base of Driver transistor Q303. Q303 supplies drive for PA transistors Q304 and Q306. Q304 is driven direct from the collector of Q303. Drive from the collector of Q303 is applied to the base of bootstrap transistor Q305. The emitter of Q305 is direct coupled to Q306.

PA transistors Q304 and Q306 operate as complementary emitter-followers, providing a 500 milliwatt output into an 8-ohm load. Audio is coupled through capacitor C329 on the receiver board to speaker LS1.

### SQUELCH

Noise from Audio Amplifier U304/U305 operates the squelch circuit. A typical squelch circuit is shown in Figure 8.

When no carrier is present in the receiver, the noise output of active high-pass filter Q1 is coupled to the base of noise amplifier Q2 through SQUELCH control R702. R702 controls the gain of the noise amplifier.

The output of noise amplifier Q2 is detected by diodes CR1 and CR2, and the resultant positive voltage turns off the PNP squelch switch Q3. In standard radios, the emitter of Q3 is connected to +7 Volts by means of a jumper from H1 to H2. When noise turns off Q3, its collector drops to ground potential. As the collector of Q3 is connected to the base of amplifier Q301 in the Audio PA module, turning off Q3 also turns off Q301, keeping the audio PA turned off.

When the receiver is quieted by a signal, squelch switch Q3 turns on. This applies +7 Volts to the base of amplifier Q1 in the Audio PA module, turning the Audio PA circuit on so that sound is heard at the speaker.

In tone decoder applications, the 7-Volt jumper from H1 to H2 is removed. The emitter of squelch switch Q3 is connected to 7.5 Volts by a DC switch on the decoder board.

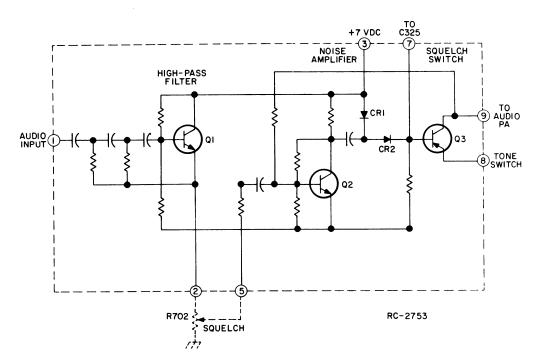


Figure 8 - Typical Squelch Circuit

				•	•

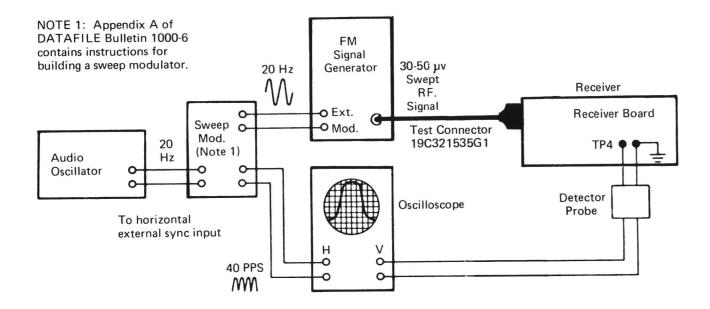


Figure 9 - Test Setup for 20-Hz Double-Trace Sweep Alignment

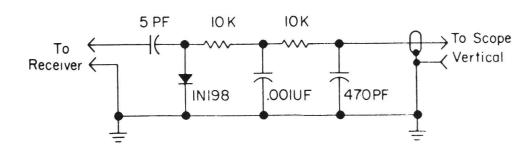
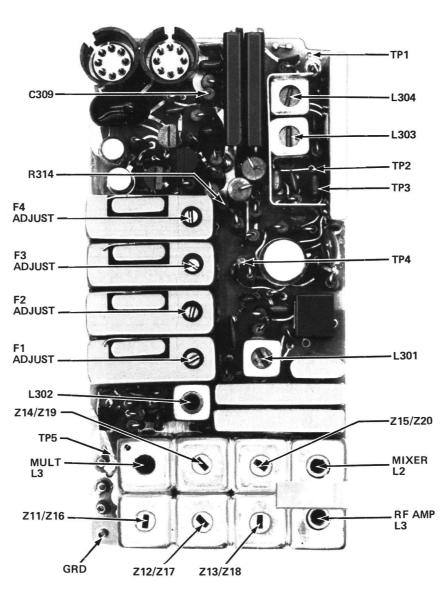


Figure 10 - Detector Probe for Sweep Alignment



# RECEIVER ALIGNMENT

LBI-4890

### EQUIPMENT

- A 23 MHz signal source (GE IF Generator Model 4EX7A10 or equivalent), a 455 kHz signal source (GE IF Generator Model 4EX7A10 or equivalent), and a 450-470 MHz source connected to the receiver through Receiver Test Connector 19C321535G1 inserted into antenna tube 19A127779G8.
- 2. GE Test Set Model 4EX3AlO or 4EX8Kll or voltmeter with equivalent sensitivity.
- 3. GE Test Amplifier Model 4EX16AlO and RF probe 19C311370Gl, or equivalent RF voltmeter.
- 4. Distortion Analyzer or AC-VTVM.
- 5. Oscilloscope, 50 MV/DIV or better

### PRELIMINARY CHECKS AND ADJUSTMENTS

- In multi-frequency receivers where the maximum frequency spacing is less than one MHz, align the receiver on the Fl channel. Where the frequency spacing is more than one MHz, align the receiver on the center frequency.
- 2. Set the slugs in Z11/Z16 thru Z15/A20 to the bottom of the coil form for frequencies in the low end of the band. Set the slugs near the top of the coil form for frequencies near the high end of the band.
- 3. Set the slug in RF AMP L3 to the top of the coil form for frequencies in the low end of the band, and near the bottom of the coil form for frequencies near the high end of the band. Set Mixer Output coil L2 near the middle of the coil form.
- 4. Connect the negative lead of the DC Test Set to TPl and the positive lead to ground. Connect the Distortion Analyzer or AC-VTVM across the

### ALIGNMENT PROCEDURE

STEP	TUNING CONTROL	PROCEDURE	
		RATIO DETECTOR .	
1. L303 Lightly couple a 455 kHz signal to U302-6. Adjust input for a slight increase at U303-12 (1 L303 for a peak.			
2.	L304	Adjust L304 to zero volts ±10 mV at TP2. Repeat steps 1 and 2. Disconnect 455 kHz generator.	
		FRONT END MULTIPLIER	
3	MULT L3	Adjust L3 for maximum meter reading at TP5.	
4.	Z14/Z19 and Z15/Z <b>2</b> 0	Adjust Z14/Z19 and then Z15/Z20 for slight change in meter reading at Tp5.	
		HIGH AND LOW IF	
		The IF Circuits have been aligned at the factory and will normally require no further adjustment. Should alignment become necessary, use the procedure outlined in Steps 5 and 6.	
5.	See Procedure	Connect the scope, signal generator and detector as shown in Figures 9 and 10. Apply an on-frequency signal using the lowest possible input level to avoid limiting. Modulate the generator with 20 Hz at 10 to 16 kHz deviation.	
		An on-frequency signal is easily determined by zero beating the channel signal with the 455 kHz marker generator signal. Loosely couple the 455 kHz generator to U301-4 and adjust the RF level of the RF signal generator to 20 dB quieting level	
6.	L2, L302, L301	Tune L2 of the mixer and L302 for the best response. Tune L301 for flatness. Retune L2, L302 and L301 for the best shape on scope as shown on scope wave form, keeping the signal below saturation.	
		FRONT END	
7.	Z11/Z16 thru Z13/Z18 and RF. Amp L3	Apply an on-frequency signal and adjust $Z11/Z16$ , $Z12/Z17$ , $Z13/Z18$ , and $L3$ for best quieting sensitivity.	
8.	MULT L3, Z14/Z19 & Z15/Z20	De-tune L3. Increase the on-frequency input signal and tune Z14/Z19 and Z15/Z20 for best quieting sensitivity. Now re-adjust L3 for maximum meter reading at TP5.	
9.	L303, L304	Re-tune the ratio detector on noise. Peak L303 at TP1. Zero TP2 by tuning L304. Detector idling should be zero volts ±10 mV.	
		FREQUENCY ADJUSTMENT	

# ALIGNMENT PROCEDURE

450—470 MHz MVP PERSONAL RECEIVER TYPE ER-72-A

Issue 2

# **TEST PROCEDURES**

These Test Procedures are designed to help you to service a receiver that is operat- refer to the "Service Check" listed to ing --- but not properly. The problems encountered could be low power, poor sensitivity, distortion, and low gain. By following the sequence of test steps starting with Step 1. the defect can be quickly localized.

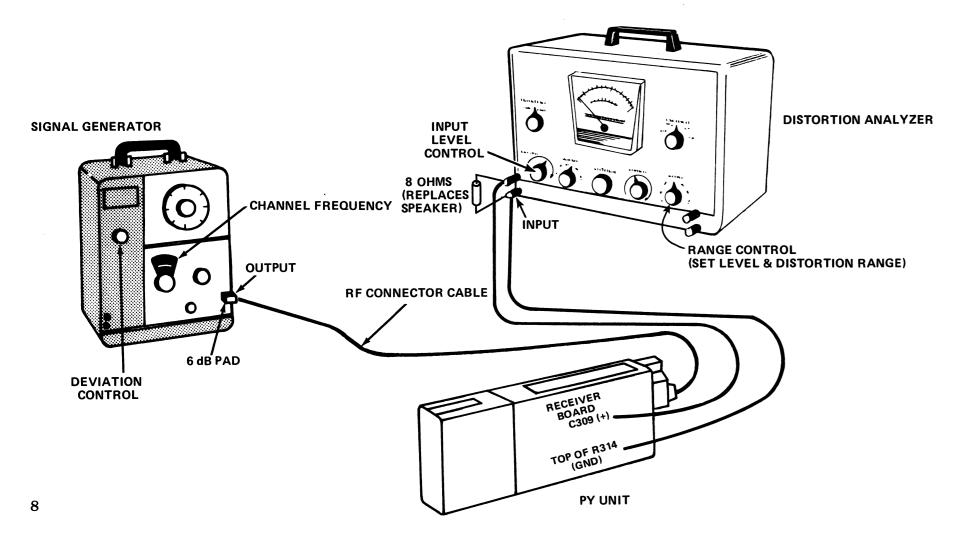
Once the defective stage is pin-pointed, correct the problem. Additional corrective measures are included in the Troubleshooting Procedure. Before starting with the Receiver Test Procedures, be sure the receiver is tuned and aligned to the proper operating frequency.

# **TEST EQUIPMENT REQUIRED**

- Distortion Analyzer similar to: Heath IM-12
- Signal Generator similar to: Measurements M-803
- 6-dB attenuation pad
- 8 ohm, 1 watt resistor
- RF Connector Cable 19C321535G1

# PRELIMINARY ADJUSTMENTS

- 1. Connect the test equipment to the receiver as shown for all steps of the receiver Test Procedure. Refer to page 7 for connection points.
- 2. Turn the SQUELCH control fully clockwise for all steps of the Test Procedure.
- 3. Turn on all of the equipment and let it warm up for 20 minutes.



# STEP 1

# **AUDIO POWER OUTPUT AND DISTORTION TEST PROCEDURE**

Measure Audio Power output as follows:

- A. Connect a 1.000-microvolt test signal modulated by 1.000 hertz ±3.0 kHz deviation to the Antenna Connector.
- B. Set the Volume Control for a 500 milliwatt output (2 volts RMS).
- C. Make distortion measurements according to manufacturer's instructions. Reading should be less than 5%-10% (5% is typical). If the receiver sensitivity is to be measured, leave all controls and equipment as they are.

# SERVICE CHECK

If the distortion is more than 5%. or maximum audio output is less than 0.5 watt, make the following checks:

- D. Battery voltage---low voltage will cause distortion. (Refer to Receiver Schematic Diagram for voltages.)
- E. Audio Gain (Refer to Receiver Troubleshooting Procedure).

# STEP 2

# **USABLE SENSITIVITY (12 dB SINAD) TEST PROCEDURE**

If STEP 1 checks out properly, measure the receiver sensitivity as follows:

- A. Apply a 1000-microvolt, on-frequency signal modulated by 1000 Hz with 3.0 kHz deviation to the Antenna Connector.
- B. Place the RANGE switch on the Distortion Analyzer in the 200 to 2000-Hz distortion range position (1000-Hz filter in the circuit). Tune the filter for minimum reading or null on the lowest possible scale (100%, 30%, etc.)
- C. Place the RANGE switch to the SET LEVEL position (filter out of the circuit) and adjust the input LEVEL control for a +2 dB reading on a mid range (30%).
- D. While reducing the signal generator output, switch the RANGE control from SET LEVEL to the distortion range until a 12-dB difference (+2 dB to -10 dB) is obtained between the SET LEVEL and distortion range positions (filter out and filter in).

- E. The 12-dB difference (Signal plus Noise and Distortion to noise plus distortion ratio) is the "usable" sensitivity level. The sensitivity should be less than rated 12 dB SINAD specification with an audio output of at least 250 milliwatts.
- F. Leave all controls as they are and all equipment connected if the Modulation Acceptance Bandwidth test is to be performed.

# SERVICE CHECK

If the sensitivity level is more than rated 12 dB SINAD, check the alignment of the RF stages as directed in the Alignment Procedure, and make the gain measurements as shown on the Troubleshooting Procedure.

# STEP 3

# MODULATION ACCEPTANCE BANDWIDTH (IF BANDWIDTH)

# **TEST PROCEDURE**

If STEPS 1 and 2 check out properly measure the bandwidth as follows:

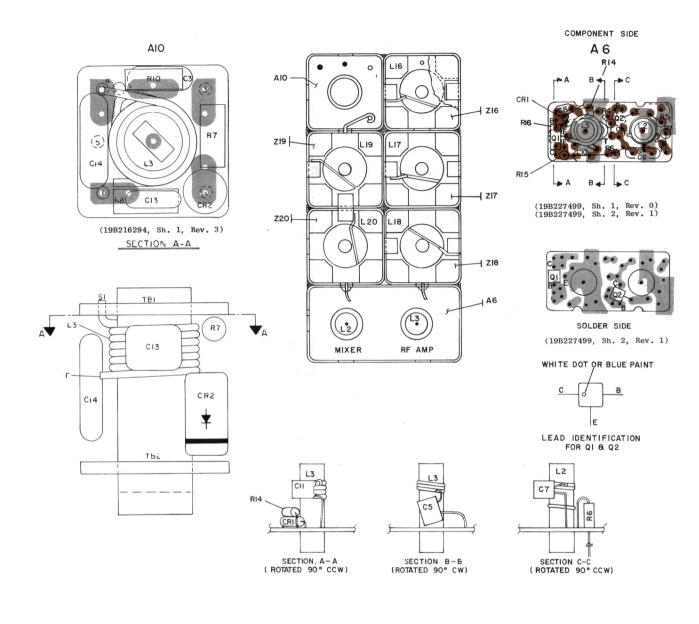
- A. Set the Signal Generator output for twice the microvolt reading obtained in the 12-dB SINAD measurement.
- B. Set the RANGE control on the Distortion Analyzer in the SET LEVEL position (1000-Hz filter out of the circuit), and adjust the input LEVEL control for a +2 dB reading on the 30% range.
- C. While increasing the deviation of the Signal Generator, switch the RANGE control from SET LEVEL to distortion range until a 12-dB difference is obtained between the SET LEVEL and distortion range readings (from +2 dB to -10 dB).
- D. The deviation control reading for the 12-dB difference is the Modulation Acceptance Bandwidth of the receiver. It should be more than ±7 kHz (but less than  $\pm 9$  kHz).

# **SERVICE CHECK**

If the Modulation Acceptance Bandwidth test does not indicate the proper width, make gain measurements as shown on the Receiver Troubleshooting Procedure.

# LBI4890

# OUTLINE DIAGRAM



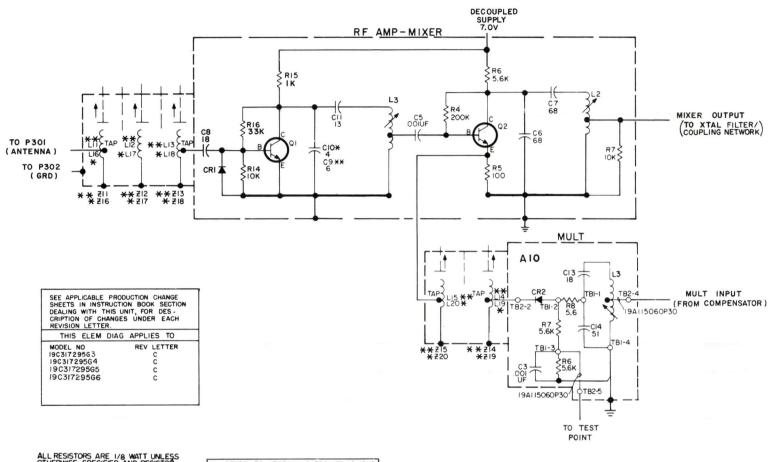
(19C328150, Rev. 0) (19C321537, Rev. 5)

# RUNS ON SOLDER SIDE RUNS ON BOTH SIDES TUNS ON COMPONENT SIDE

# OUTLINE & SCHEMATIC DIAGRAM

450—470 MHZ RECEIVER FRONT END (A307) TYPE ER-72-A

SCHEMATIC DIAGRAM



ALL RESISTORS ARE 1/8 WATT UNLESS OTHERWISE SPECIFIED AND RESISTOR VALUES IN OHMS UNLESS FOLLOWED BY K-1000 OHMS OR MEG +1000,000 OHMS CAPACITOR VALUES IN PICOFARADS (EQUAL TO MICROMICROFARADS) UNLESS FOLLOWED BY UF- MICROFARADS. INDUCTANCE VALUES IN MICROFILMENTY ON LIESS FOLLOWED BY MH= MILLIHENRYS OR H=HENRYS.

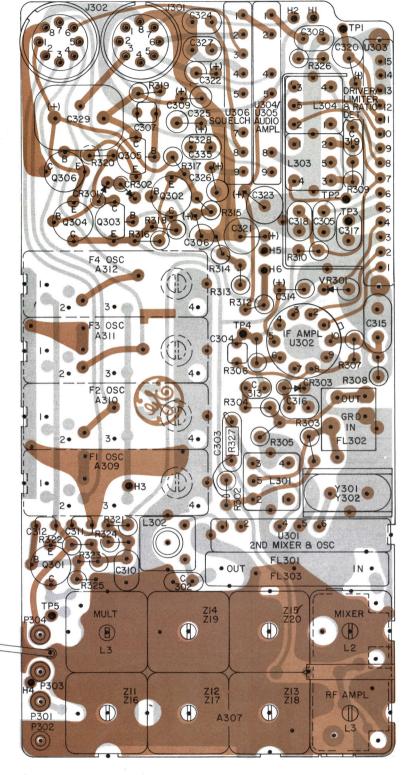
IN ORDER TO RETAIN RATED EQUIPMENT PERFORMANCE, REPLACEMENT OF ANY SERVICE PART SHOULD BE MADE ONLY WITH A COMPONENT HAVING THE SPECIFICATIONS SHOWN ON THE PARTS LIST FOR THAT PART

\* HI SPLIT (450-470)

\*\* LO SPLIT (406-420)

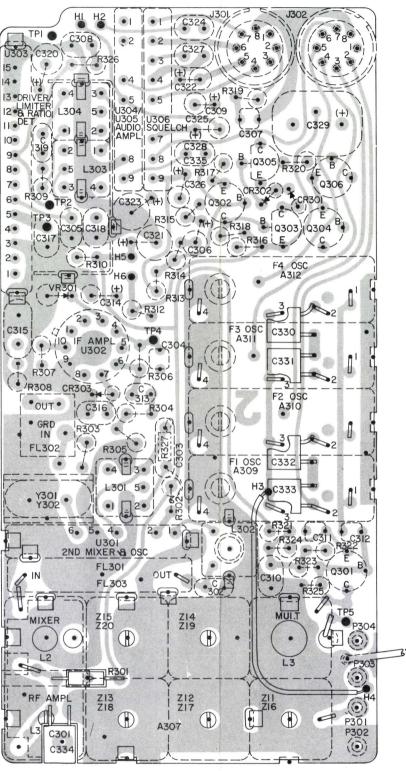
(19C320887, Rev. 7)

# COMPONENT SIDE



(19D423092, Sh. 2, Rev. 2) (19D423092, Sh. 3, Rev. 1)

SOLDER SIDE



(19D423092, Sh. 2, Rev. 2)

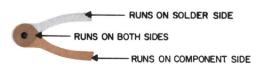
# (19D423382, Rev. 4)

# OUTLINE DIAGRAM

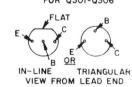
10

450—470 MHz MVP PERSONAL RECEIVER TYPE ER-72-A

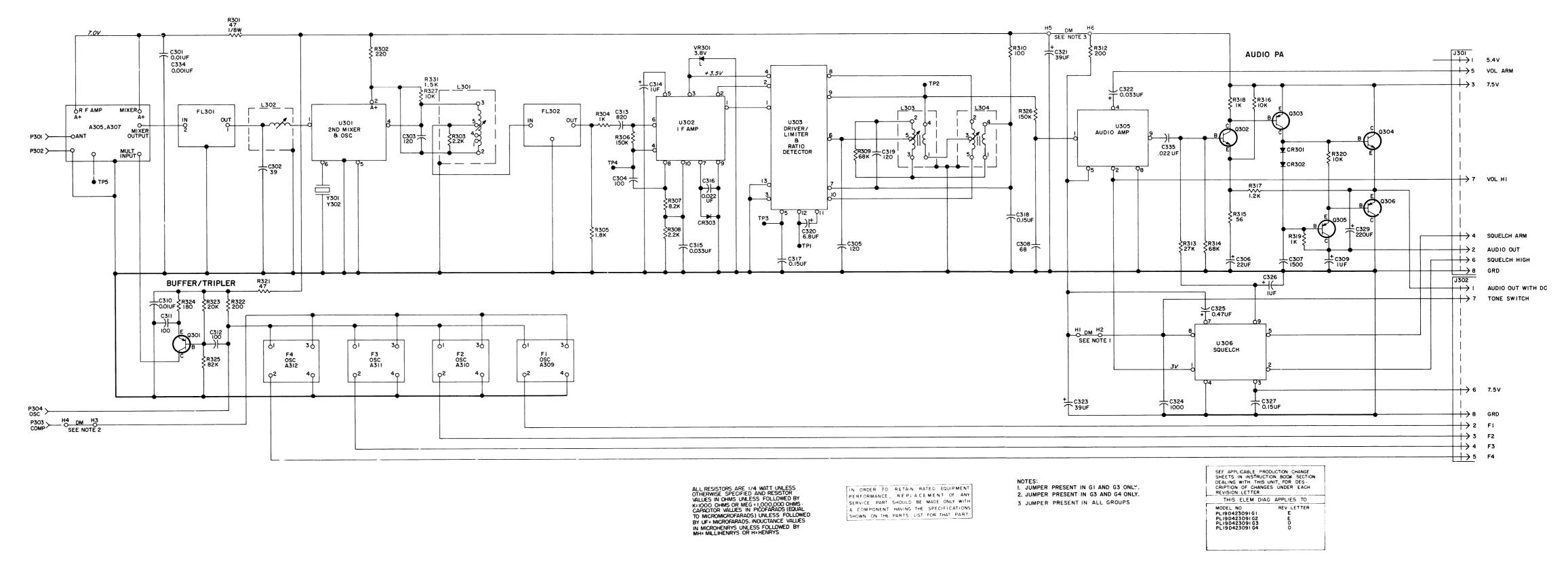
Issue 3



LEAD IDENTIFICATION FOR Q301-Q306



NOTE: LEAD ARRANGEMENT, AND NOT CASE SHAPE, IS DETERMINING FACTOR FOR LEAD IDENTIFICATION.



• •

# SCHEMATIC DIAGRAM

11

450—470 MHz MVP PERSONAL RECEIVER TYPE ER-72-A LBI4890

# PARTS LIST

LB14891E

450-470 MHz RECEIVER ER-72-A

SYMBOL	GE PART NO.	DESCRIPTION
A307		FRONT END ASSEMBLY 19C317295G6
A6*		RF AMPLIFIER 19C317445G4 (Added by REV C)
C5	5495323P12	Ceramic: .001 μf +100% -20%, 75 VDCW.
C6 and C7	19A116114P4059	Ceramic: 68 pf ±5%, 100 VDCW; temp coef -220
C8	19A116114P6038	Ceramic: 18 pf ±5%, 100 VDCW; temp coef -470
C10	19A116114P2014	Ceramic: 4 pf ±5%, 100 VDCW; temp coef -80 PP
C11	19All6ll4P2035	Ceramic: 13 pf ±5%, 100 VDCW; temp coef -80 P
CR1	19A116052P1	DIODES AND RECTIFIERS
CHI	154110052F1	STITEON.
L2	19B216948G1	Coil.
L3	19A128005G1	Coil. Includes:
	19B209436P1	Tuning slug.
		TRANSISTORS
Q1 and Q2	19A116159P1	Silicon, NPN.
		RESISTORS
R4	3R151P204J	Composition: 200K ohms ±5%, 1/8 w.
R5	3R151P101J	Composition: 100 ohms ±5%, 1/8 w.
R6	3R151P562J	Composition: 5.6K ohms ±5%, 1/8 w.
R7	3R151P103J	Composition: 10K ohms ±5%, 1/8 w.
R14	3R151P103J	Composition: 10K ohms ±5%, 1/8 w.
R15	3R151P102J	Composition: 1K ohms ±5%, 1/8 w.
R16	3R151P333J	Composition: 33K ohms ±5%, 1/8 w.
A6*		RF AMPLIFIER 19C317445G4 (Deleted by REV C)
C5	5495323Pl2	Ceramic: .001 µf +100% -20%, 75 VDCW.
C6 and	19A116114P4059	Ceramic: 68 pf ±5%, 100 VDCW; temp coef -220 F
C7 C8	19A116114P6038	
C10	19A116114P2014	*Ceramic: 4 pf ±5%, 100 VDCW; temp coef -80 PPM
C11	9A116114P2035	Ceramic: 13 pf ±5%, 100 VDCW; temp coef -80 PP
:		DIODES AND RECTIFIERS
CR1	19A116052P1	Silicon.
L2	19B216948G1	Coil.
L3	19A128005G1	Coil. Includes:
	19B209436P1	Tuning slug.

12 L L L L \*COMPONENTS ADDED, DELETED OR CHANGED BY PRODUCTION CHANGES

SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION	s	SYME
		TRANSISTORS					L302
Q1 and	19A116159P1	Silicon, NPN.	C302	19A116114P2050	Ceramic: 39 pf ±5%, 100 VDCW; temp coef -80 PPM.		
Q2		RESISTORS	C303	19A116114P5068	Ceramic: 120 pf ±5%, 100 VDCW; temp coef -330 PPM	l l	L303
R4	3R151P204J	Composition: 200K ohms ±5%, 1/8 w.	C304	19A116114P13064	Ceramic: 100 pf ±10%, 100 VDCW; temp coef -5600	L	L304
R5	3R151P101J	Composition: 100 ohms ±5%, 1/8 w.	C305	19A116288P9	Ceramic: 120 pf ±5%, 100 VDCW; sim to Erie 8121-		
R6	3R151P562J	Composition: 5.6K ohms ±5%, 1/8 w.			A100-U2J-121J.	P	P301
R7	3R151P103J	Composition: 10K ohms ±5%, 1/8 w.	C306	5491674P35	Tantalum: 22 $\mu f$ $\pm 20\%$ , 4 VDCW; sim to Sprague Type 162D.		hru 2304
R14	3R151P103J	Composition: 10K ohms ±5%, 1/8 w.	C307	19A116192P10	Ceramic: 1500 pf ±20%, 50 VDCW; sim to Erie		
R15	3R151P102J	Composition: 1K ohms ±5%, 1/8 w.	C308	19A116114P6059	8121-050-W5R.  Ceramic: 68 pf ±5%, 100 VDCW; temp coef -470 PPM.	Q	301
R16	3R151P333J	Composition: 33K ohms ±5%, 1/8 w.	C309	5491674P28	Tantalum: 1.0 µf ±20%, 25 VDCW; sim to Sprague	9	302
AlO		MULTIPLIER			Type 162D.		9303
		19C311873G7	C310	19A116192P1	Ceramic: 0.01 $\mu f$ $\pm 20\%$ , 50 VDCW; sim to Erie 8121 SPECIAL.		304
			C311 and	19A116114P13064	Ceramic: 100 pf ±10%, 100 VDCW; temp coef -5600 PPM.		306
C3	5495323P12	Ceramic: .001 µf +100% -20%, 75 VDCW.	C312				
C13	19A116114P2038 19A116114P2054	Ceramic: 18 pf ±5%, 100 VDCW; temp coef -80 PPM.  Ceramic: 51 pf ±5%, 100 VDCW; temp coef -80 PPM.	C313	19A116192P9	Ceramic: 820 pf ±20%, 50 VDCW; sim to Erie 8111-050-W5R.		301
	134110114F2034		C314	5491674P28	Tantalum: 1.0 µf ±20%, 25 VDCW; sim to Sprague Type 162D.		301
ČR2	19A116809P1	DIODES AND RECTIFIERS Silicon.	C315	19A116080P104	Polyester: 0.033 $\mu$ f $\pm$ 10%, 50 VDCW.	R:	303
CKZ	194110809P1	Silicon.	C316	19A116244P2	Ceramic: 0.022 µf ±20%, 50 VDCW.	R	304
			C317 and	19A116244P4	Ceramic: 0.15 μf ±20%, 50 VDCW.	R:	305
L3	19B216296P3	Coil. Includes:	C318			R	306
	19B200495P5	Tuning slug.	C319	19A116114P7068	Ceramic: 120 pf ±5%, 100 VDCW; temp coef -750 PPM.	- 1	307
		RESISTORS	C320	5496267P1	Tantalum: 6,8 µf ±20%, 6 VDCW; sim to Sprague Type 150D.	- 1	308 309
R7 R8	3R151P562J 3R151P5R6J	Composition: 5.6K ohms ±5%, 1/8 w.	C321	5491674P30	Tantalum: 39 μf ±20%, 10 VDCW; sim to Sprague	R	310
R10	3R151P562J	Composition: 5.6 ohms $\pm 5\%$ , $1/8$ w.  Composition: 5.6K ohms $\pm 5\%$ , $1/8$ w.	C322	5491674P31	Type 162D.	R	312
	0	Composition. J. ok olums 15 c, 1/6 w.	C322	3491074P31	Tantalum: .033 μf ±20%, 35 VDCW; sim to Sprague Type 162D.	RS	313
			C323	5491674P30	Tantalum: 39 µf ±207, 10 VDCW; sim to Sprague Type 162D.	- 1	314
L16	19B216439G7 19C311750P1	Helical resonator. (Part of Z16). Includes: luning slug.	C324	19A116192P13	Ceramic: 1000 pf ±10%, 50 VDCW; sim to Erie 8121-A050-W5R.	1	315 316
L17	19B216439G2	Helical resonator. (Part of Z17). Includes:	C325	5491674P27	Tantalum: .47 μf ±20%, 35 VDCW; sim to Sprague	- 1	317
	19C311750P1	Tuning slug.	C326	5491674P28	Type 162D.  Tantalum: 1.0 µf ±20%, 25 VDCW; sim to Sprague		318 nd
L18	19B216439G1	Helical resonator, (Part of Z18), Includes:			Type 162D.	R3	319
L19	19C311750P1 19B216439G4	Tuning slug,	C327	19A116244P4	Ceramic: 0.15 µf ±20%, 50 VDCW.	- 1	320
1113	19C311750P1	Helical resonator. (Part of Z19). Includes: Tuning slug.	C328*	19A116244P5 19A116178P7	Ceramic: 0.1 µf ±20%, 50 VDCW. Deleted by REV C.  Tantalum: 220 µf ±20%, 6 VDCW.	1	321 322
L20	19B216439G3	Helical resonator. (Part of Z20). Includes:	C330*	19A116192P13	Ceramic: 1000 pf ±10%, 50 VDCW; sim to Erie	- 1	323
	19C311750P1	Tuning slug.	thru C333*		8121-A050-W5R. Deleted by REV B.	- 1	324
		HELICAL RESONATORS	C334	19A116192P13	Ceramic: 1000 pf $\pm 10\%$ , 50 VDCW; sim to Erie 8121-A050-W5R.	R3	325
<b>Z</b> 16		Consists of L16 and 19D413132P24 can.	C335*	19A116192P6	Ceramic: 0.022 μf ±20%, 50 VDCW; sim to Erie	1	326
Z17		Consists of L17 and 19D413132P3 can.			8131-M050-W5R. Added by REV C.	R3	327*
Z18		Consists of L18 and 19D413132P25 can.			DIODES AND RECTIFIERS	1	
Z19		Consists of L19 and 19D413132P19 can.	CR301 thru	19A115250P1	Silicon, fast recovery, 225 mA, 50 PIV.	U3	301
Z20		Consists of L20 and 19D413132P20 can.	CR303			1	302
		RECEIVER BOARD	PT 000	10110110071		- 1	303
		19D423O91G3 STANDAND 19D423O91G4 CHANNEL GUARD	FL302 FL303	19A134199P1 19C304824G3	Bandpass: 20 KHz at 6 db, 40 KHz at 40 db.  Bandpass: 23 MHz.	1	305 306
		OSCILLATORS	12303	15030482403	Danupass. 25 mnz.	"	.00
					JACKS AND RECEPTACLES		
A309 thru		NOTE: When reordering, give GE Part Number and specify exact frequency needed.	J301 and	19A116122P1	Terminal, feed-thru.	VR	301
A312	4EG28A28	Oscillator Module. 450-470 MHz. Fx = <u>Fo - 23</u>	J302		INDICTORS		
	110 20020	21	L301	19A116308P3	IF Transformer: sim to Toko, Inc. LMN-6586Y.	үз	802
					- Interest - Am to toke, Airt, Link-50001,		
			1			1	

SYMBOL	GE PART NO.	DESCRIPTION	SYMBOL	GE PART NO.	DESCRIPTION
L302	19B219864G4	Coil. Includes:			
	19B209436P1	Tuning slug.		10411647771	MISCELLANEOUS
L303	19A116308P1	IF Transformer: sim to Toko, Inc. LSN4816VE2.		19A116477P1	Machine screw: 5/32. (Secures A307).
L304	19A116308P2			19B216316P1	Insulator. (Used with J301, J302).
2001	10,111000012	IF Transformer: sim to Toko, Inc. LSN4817YM2.	ļ	19A116120P1	Can. (Used with L302).
			1	19B226696P1	Shield. (Located at L303, L304).
P301 thru P304	19All5834P4	Contact, electrical: sim to AMP 2-332070-9.		19B219802P2 19B200497P5	Shield, (Located over AlO and L16-L20), Tuning slug, (Used with Multiplier).
		TRANSISTORS			
Q301	19A116223P1	Silicon, PNP; sim to Type 2N3640.			ASSOCIATED ASSEMBLIES
Q302	19A116774P1	Silicon, NPN; sim to Type 2N5210.	1		CONNECTOR KIT
Q303	19A115852P1	Silicon, PNP; sim to Type 2N3906.	İ		19C321535G1
Q304	19A115720P1	Silicon, NPN; sim to Type 2N2222.			
Q305	19A115852P1	Silicon, PNP; sim to Type 2N3906.	C1	19A116114P1	Ceramic: 1 pf ±10%, 100 VDCW; temp coef 0 (Part of W1).
Q306	19A134165P1	Silicon, PNP; sim to Type 2N2906A.	C2	19All6114P1	(Part of W1).  Ceramic: 1 of ±10%, 100 VDCW; temp coef 0
2001		RESISTORS			JACKS AND RECEPTACLES
R301	3R151P470J	Composition: 47 ohms ±5%, 1/8 w.	J1	7776570P17	Receptacle, bulkhead: coaxial, 500 v peak
R302	3R152P221J	Composition: 220 ohms ±5%, 1/4 w.			Military Type MS35179 REV.B-1094/U.
R303	3R152P222J	Composition: 2.2K ohms ±5%, 1/4 w.			
R304	3R152P102J	Composition: 1K ohms ±5%, 1/4 w.	Wl	198 <b>226852</b> G1	Cable assembly. Includes C1.
R305	3R152P182J	Composition: 1.8K ohms ±5%, 1/4 w.		1002200231	cable assembly. Includes CI.
R306	3R152P154J	Composition: 150K ohms ±5%, 1/4 w.			
R307	3R152P822J	Composition: 8.2K ohms ±5%, 1/4 w.			
R308	3R152P222J	Composition: 2.2K ohms ±5%, 1/4 w.			
R309	3R152P683J	Composition: 68K ohms ±5%, 1/4 w.	1		
R310	3R152P101J	Composition: 100 ohms ±5%, 1/4 w.			
R312	3R152P201J	Composition: 200 ohms ±5%, 1/4 w.			
R313	3R152P273J	Composition: 27K ohms ±5%, 1/4 w.			
R314	3R152P683J	Composition: 68K ohms ±5%, 1/4 w.			
R315	3R152P560J	Composition: 56 ohms ±5%, 1/4 w.			
R316	3R152P103J	Composition: 10K ohms ±5%, 1/4 w.	1		
R317	3R152P122J	Composition: 1.2K ohms ±5%, 1/4 w.			
R318 and R319	3R152P102J	Composition: 1K ohms ±5%, 1/4 w.			
R320	3R152P103J	Composition: 10K ohms ±5%, 1/4 w.	1 1		
R321	3R152P470J	Composition: 47 ohms ±5%, 1/4 w.	1 1		
R322	3R152P221J	Composition: 220 ohms ±5%, 1/4 w.			
R323	3R152P203J	Composition: 20K ohms ±5%, 1/4 w.			
R324	3R152P181J	Composition: 180 ohms ±5%, 1/4 w.			
R325	3R152P823J	Composition: 82K ohms ±5%, 1/4 w.			
R326	3R152P154J	Composition: 150K ohms ±5%, 1/4 w.			
R327*	3R151P103J	Composition: 10K ohms ±5%, 1/8 w. Added by REV D.			
		INTEGRATED CIRCUITS			
U301	19C321359G1	2nd Oscillator, Mixer.			
U302	19A116208P2	Monolithic, linear.			
U303	19D423113G1	Detector,			
U305	19C311995G4	Audio Amplifier, (Includes Tone Filter).			
U306	19C311880G4	Squelch.			
l					
VR301	4036887P3	Zener: 500 mW, 1.0 PIV.			
Y302	19B206357G11	Quartz: 23.455 MHz, temp range -30°C to +85°C.			
1					

PRODUCTION CHANGES
PRODUCTION CHANGES
anges in the equipment to improve performance or to simentified by a "Revision Letter", which is stamped after the unit. The revision stamped on the unit includes a sions. Refer to the Parts List for descriptions of parese revisions.

REV C - To eliminate manufactor of non-Channel Guard receiver boards, Deleted from Schematic Diagram call out of U304, C328, lwf and circle (•) in front of C335. Deleted Note: • Used for Channel Guard receivers.

REV. D -To improve stability. Added R327.

simplify circuits are ter the model number s all previous re-parts affected by

. .

REV A & B - Receiver Front End 19C317295G6
Incorporated in initial shipment.

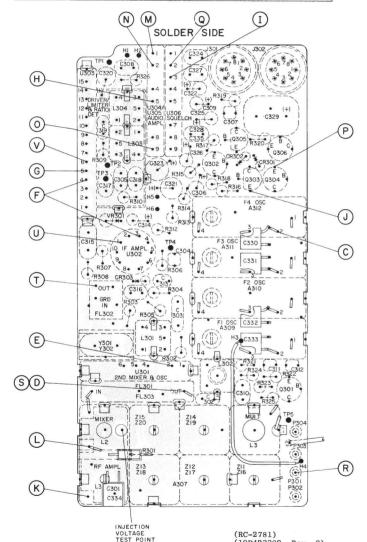
REV C - To improve ease in assembly, troubleshooting and repairing. Changed RF Amp/Mixer.

REV A - Receiver Board 19D423091G3 & G4
To improve attack time with Channel Guard Option.
Relocated C325.

REV B - To improve reliability, Deleted C330 through C333.

# QUICK CHECKS

SYMPTOM	PROCEDURE
No Audio	Check audio waveform at the top of the Volume Control (see Step 2).      If audio is present, check voltage readings of Audio and Squelch modules (see Schematic Diagram).
	3. If audio is not present, check gain and current readings of Front End and IF modules (see Steps 1 & 3).
Poor Sensitivity	1. Measure the gain of the Mixer stage (see Step 3). If low, measure the gain of the RF amplifier and IF modules.
Improper Squelch Operation	1. Check the noise waveform at the input to the Squelch module and at Squelch Con- trol high (see Step 2).
	2. Measure the DC voltages for the Squelch module (squelched and unsquelched).



STEP 3 - RF GAIN CHECKS

EQUIPMENT REQUIRED:

# STEP 3-RF GAIN CHECKS (STEPS R THRU V)

When checking the current of Audio PA module A311, do not short Pin 4 to ground or to + (Pin 5). To

do so will destroy the Audio PA module.

- 1. RF probe and Test Amplifier Model 4EX16A10 connected to GE Test Set Model 4EX3All, or an RF voltmeter.
- 2. A signal generator (M-800 or equivalent) connected to P301 (High) and P302 (Low).

### PROCEDURE FOR MIXER AND 1ST IF:

- 1. Disable 2nd Oscillator by shorting Y301 with a .01  $\mu f$  capacitor.
- 2. Switch the Test Set to the Test 1 position and the Test
- 3. Connect the RF probe across the input (R) as shown on the
- 4. Connect the RF probe to the output (S) as shown on the diagram. Decrease the generator output until the Test Set reference reading in Step 3 is obtained. Note the dB reading
- 5. Subtract the dBl reading from the dB2 reading and check the

3. Now substract dB2 from dB1 to obtain the gain of the 2nd

# PROCEDURE FOR 2ND IF AMPLIFIER:

- at (T). Increase the signal generator output to obtain a reference level on Test Set 4EX3All. Note the Test Set reading and the dB reading on the generator (dB1).
- 2. Connect the RF probe to the output at U as shown on the diagram. Decrease the generator output until the Test Set reference reading in Step 1 is obtained. Note the dB reading
- results with the typical gains on the diagram.

check to determine if the module is limiting.

- 1. Switch the Test Amplifier to the XI position and the Test Set to the Test 1 position. Then connect the RF probe to the output of the Limiter module v and check for a reading of approximately 0.25 VPC.
- 2. Increase the signal generator output. There should be no appreciable increase in the limiter output meter reading.

- Amplifier to the X50 position.
- diagram. Increase the signal generator output to obtain a reference reading on Test Set 4EX3All. Note the Test Set reading and the dB reading on the generator (dB1).
- on the generator (dB2).
- results with the typical gains shown on the diagram.

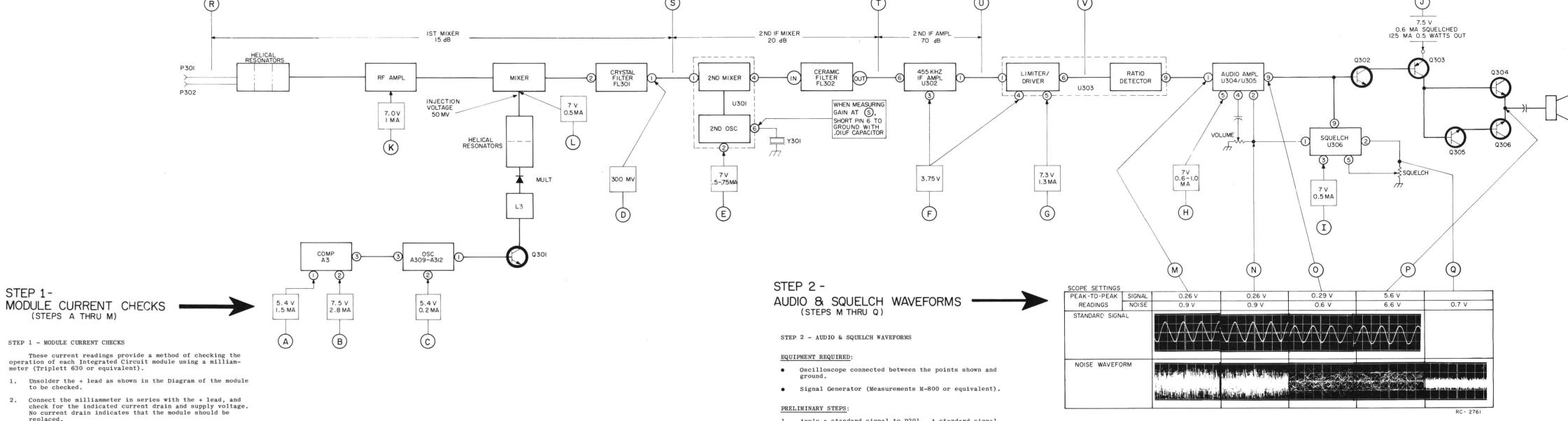
Remove .01 μf shorting capacitor.

### PROCEDURE FOR 2ND MIXER:

- With no signal in, connect the RF probe to the output of the 2nd IF filter FL302 at (T). Increase the signal generator output until the Test Set reading increases by approximately 0.2 volt. Note Test Set and signal generator reading (dB2).
- 2. Connect the probe to the input of the 2nd Mixer module at (S) Increase the signal generator until the Test Set reference reading is obtained, and note the dB reading (dBl).

- Connect the RF probe across the input of the 2nd IF Amplifier
- 3. Subtract the dBl reading from the dB2 reading and check the

The limiter module limits on noise so that the gain of the circuit cannot be measured. The following procedure provides a



1. Apply a standard signal to P301. A standard signal is 1000 microvolts on the receiver frequency modulated

by one kHz with 3.0-kHz deviation.

2. Set the Volume control for 0.5-watt output.

# TROUBLESHOOTING PROCEDURE

LBI-4890

450—470 MHz MVP PERSONAL RECEIVER TYPE ER-72-A

Issue 2